

MOSFET - Power, Single N-Channel, Source Down, WDFN9

40 V, 1.3 mΩ, 207 A

NTTFSSH1D3N04XL

Features

- Advanced Source–Down Package Technology (3.3x3.3mm) with Excellent Thermal Conduction
- Low R_{DS(on)} to Minimize Conduction Loss
- Low QRR with Soft Recovery to Minimize ERR Loss and Voltage Spike
- Low Q_G and Capacitance to Minimize Driving and Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- High Switching Frequency DC-DC Conversion
- Synchronous Rectifier

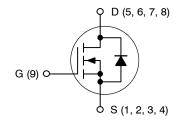
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V _{DSS}	40	V	
Gate-to-Source Voltage	DC	V _{GS}	±20	V
Continuous Drain Current	T _C = 25°C	I _D	207	Α
	T _C = 100°C		146	
Power Dissipation	T _C = 25°C	P _D	107	W
Pulsed Drain Current	$T_C = 25^{\circ}C$, $t_p = 100 \mu s$	I _{DM}	812	Α
Operating Junction and Storage T Range	T _J , T _{stg}	-55 to +175	°C	
Continuous Source-Drain Current (Body Diode)	I _S	184	Α	
Single Pulse Avalanche Energy (I	E _{AS}	135	mJ	
Lead Temperature for Soldering P (1/8" from case for 10 s)	TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 1 in² pad size, 1 oz Cu pad.
- 3. E_{AS} of 135 mJ is based on started T_J = 25°C, I_{AS} = 52 A, V_{DD} = 32 V, V_{GS} = 10 V, 100% avalanche tested.

V _{(BR)DSS}	R _{DS(ON)} MAX I _D MAX	
40 V	1.3 mΩ @ 10 V	207 A
40 V	1.7 mΩ @ 4.5 V	207 A



N-CHANNEL MOSFET

MARKING DIAGRAM



WDFN9 CASE 511EB



1D3N04 = Specific Device Code A = Assembly Location

WL = Wafer Lot Y = Year WW = Work Week

ORDERING INFORMATION

See detailed ordering and shipping information on page 3 of this data sheet.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Bottom)	$R_{\theta JCB}$	1.4	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	60	

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	ΔV _{(BR)DSS} / ΔT _J	I _D = 1 mA, Referenced to 25°C		17		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, T _J = 25°C			10	μΑ
		V _{DS} = 40 V, T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R _{DS(ON)}	V _{GS} = 10 V, I _D = 24 A		1.0	1.3	mΩ
		V _{GS} = 6 V, I _D = 24 A		1.1	1.4	
		V _{GS} = 4.5 V, I _D = 19 A		1.4	1.7	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 120 \mu A$	1.3		2.2	٧
Gate Threshold Voltage Temperature Coefficient	ΔV _{GS(TH)} / ΔT _J	$V_{GS} = V_{DS}, I_D = 120 \mu A$		-5		mV/°C
Forward Transconductance	9 _{FS}	V _{DS} = 5 V, I _D = 24 A		123		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE					
Input Capacitance	C _{ISS}			3480		pF
Output Capacitance	C _{OSS}	V 0VV 00V 4 MI		920		1
Reverse Transfer Capacitance	C _{RSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}, f = 1 \text{ MHz}$		32		1
Output Charge	Q _{OSS}			35		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DD} = 20 V; I _D = 24 A		21		1
		V _{GS} = 6 V, V _{DD} = 20 V; I _D = 24 A		28		
				47		
Threshold Gate Charge	Q _{G(TH)}			5.7		
Gate-to-Source Charge	Q _{GS}	V_{GS} = 10 V, V_{DD} = 20 V; I_{D} = 24 A		10		
Gate-to-Drain Charge	Q_{GD}			3.4		
Gate Plateau Voltage	V _{GP}			2.9		V
Gate Resistance	R_{G}	f = 1 MHz		0.6		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}			18		ns
Rise Time	t _r	Resistive Load,		5		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 0/10 V, V_{DD} = 20 V, I_{D} = 24 A, R_{G} = 2.5 Ω		43		1
Fall Time	t _f			4		1
SOURCE-TO-DRAIN DIODE CHARACTI	ERISTICS		-		-	-
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_S = 24 \text{ A}, T_J = 25^{\circ}\text{C}$		0.79	1.2	V
		V _{GS} = 0 V, I _S = 24 A, T _J = 125°C		0.65		1

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

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Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
SOURCE-TO-DRAIN DIODE CHARACTERISTICS						
Reverse Recovery Time	t _{RR}			17		ns
Charge Time	t _a	V _{GS} = 0 V, I _S = 24 A,		10		
Discharge Time	t _b	dl/dt = 1000 A/μs, V _{DD} = 20 V		7		
Reverse Recovery Charge	Q_{RR}			84		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTTFSSH1D3N04XL	1D3N04	WDFN9 (Pb–Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

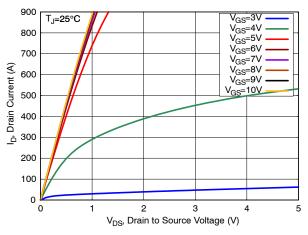


Figure 1. On-Region Characteristics

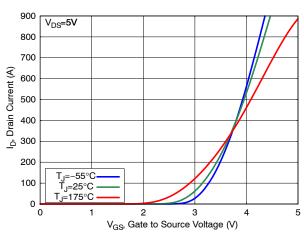


Figure 2. Transfer Characteristics

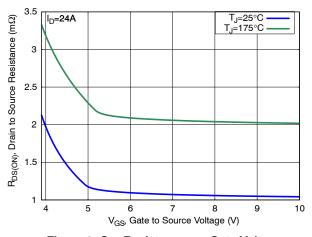


Figure 3. On-Resistance vs. Gate Voltage

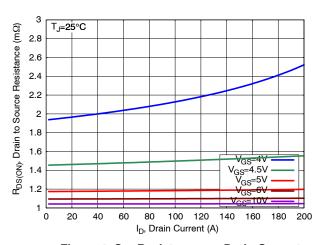


Figure 4. On-Resistance vs. Drain Current

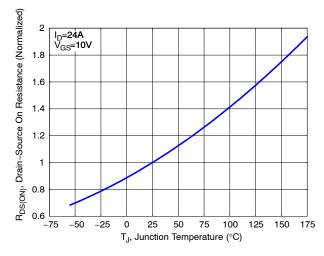


Figure 5. Normalized ON Resistance vs. Junction Temperature

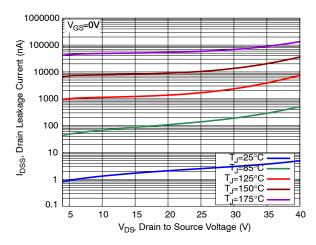


Figure 6. Drain Leakage Current vs. Drain Voltage

TYPICAL CHARACTERISTICS

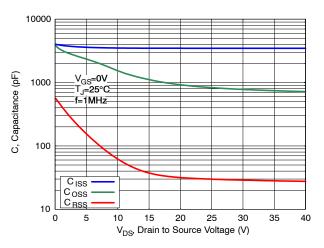


Figure 7. Capacitance Characteristics

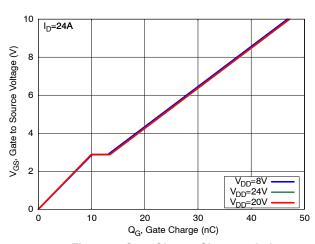


Figure 8. Gate Charge Characteristics

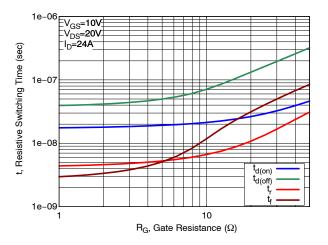


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

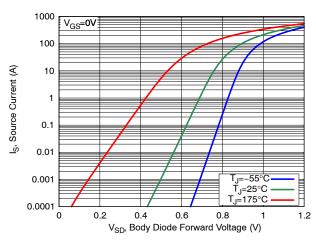


Figure 10. Diode Forward Characteristics

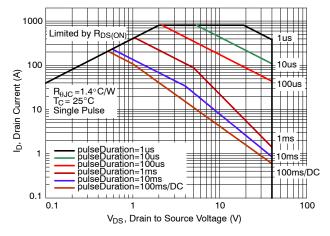


Figure 11. Safe Operating Area (SOA)

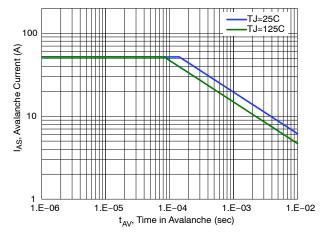
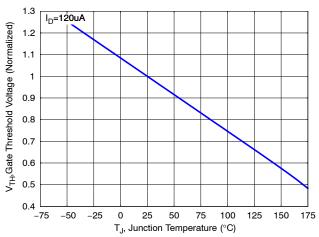


Figure 12. Avalanche Current vs. Pulse Time (UIS)

TYPICAL CHARACTERISTICS



1000 1.0e-06 1.0e-05 1.0e-04 1.0e-03 1.0e-02 1.0e-01 1.0e+00 Pulse Width(s)

Figure 13. Gate Threshold Voltage vs. Junction Temperature

Figure 14. IDM vs. Pulse Width

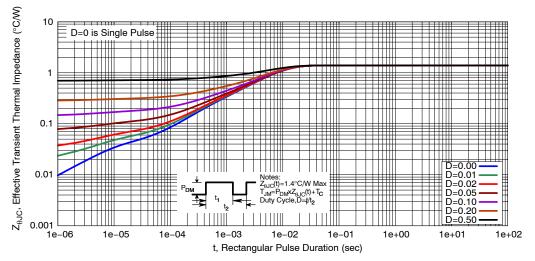


Figure 15. Transient Thermal Response





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0.10 A

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PIN 1

INDICATOR

WDFN9 3.3x3.3, 0.65P

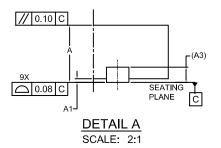
CASE 511EB **ISSUE B**

DATE 21 JUL 2021

NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETERS
 2. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.

 3. DIMENSIONS D1, D2, E1 AND E2 DO NOT
- INCLUDE MOLD FLASH.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.



UNIT IN MILLIMETER DIM NOM MIN MAX 0.70 0.75 0.80 0.02 0.00 0.05 А3 0.20 RE b 0.30 b2 0.37 0.47 0.42 D 3.30 3.40 3.20 D1 2.31 2.41 2.51 D2 1.58 1.68 1.78 D3 2.31 2.41 2.51 Е 3.20 3.30 3.40 E1 1.50 1.60 1.70 0.94 1.04 E2 0.84 E3 0.25 0.20 E4 0.35 0.45 0.55 е 0.650 BSC e/2 0.325 BSC k 0.75 REF k1 0.45 REF 0.73 0.93 0.83 L1 0.10 0.20 0.30

0.50

0.60

0.40

L4



A

□ 0 10 B

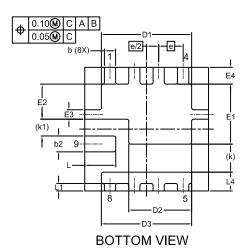
SEE DETAIL A

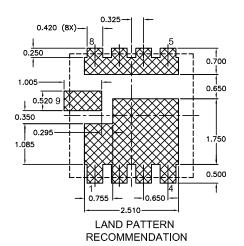
FRONT VIEW

TOP VIEW

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*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXXXX XXXXXX **AWLYWW** XXXX = Specific Device Code

= Assembly Location

= Wafer Lot WI = Year

= Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN9 3.3x3.3, 0.65P		PAGE 1 OF 1	

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